



650V Enhancement-Mode GaN Power Transistor

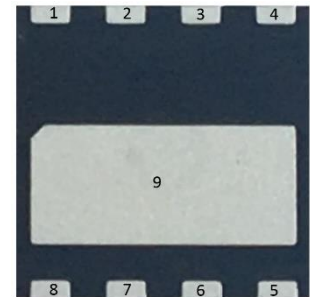
Description

The series of devices are enhancement mode GaN on silicon power transistors. The properties of GaN allow for high voltage breakdown and high switching frequency. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{DS(ON)}$ and Q_g , offer improved efficiency over silicon power transistor.



Features

- Ultra fast switching
- No reverse-recovery charge
- Capable of reverse conduction
- Low gate charge, low output charge
- Qualified for standard grade applications according to JEDEC



Application

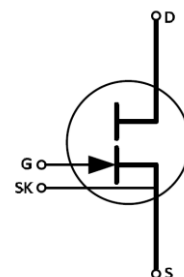
- High Voltage AC/DC conversion
- High Voltage DC/DC conversion
- High performance power supplies

| | |
|---------|---------------|
| 1,2,3,4 | Drain |
| 5,6,9 | Source |
| 7 | Kelvin Source |
| 8 | Gate |

Key performance Parameters at $T_j=25\text{ }^\circ\text{C}$

| Parameter | Value | Unit |
|------------------|-------|------------|
| $V_{DS,max}$ | 650 | V |
| $R_{DS(ON),typ}$ | 170 | m Ω |
| $Q_{G,typ}$ | 2.0 | nC |
| I_D | 13 | A |
| Q_{rr} | 0 | nC |

Schematic Diagram



Package Marking and Ordering Information

| Device | Package | Quantity |
|------------|---------|----------|
| CGL65R190B | PQFN | |

**Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$ unless otherwise noted)**

| Parameter | Symbol | Limit | Unit |
|---|-----------|------------|--------------------|
| Drain-Source Voltage | V_{DS} | 650 | V |
| Gate-Source Voltage | V_{GS} | -10 to +7 | V |
| Continuous Drain Current | I_D | 13 | A |
| Continuous Drain Current($T_C=100^{\circ}\text{C}$) | | 8 | A |
| Pulse Drain Current(Pulse width 300 μs) | I_{DM} | 20 | A |
| Operating Junction Temperature | T_J | -55 to 150 | $^{\circ}\text{C}$ |
| Storage Temperature | T_{STG} | -55 to 150 | $^{\circ}\text{C}$ |

Thermal Characteristic

| | | | |
|--|-----------------|-----|----------------------|
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 1.5 | $^{\circ}\text{C/W}$ |
| Thermal Resistance, Junction-to-Ambient ^a | $R_{\theta JA}$ | 62 | $^{\circ}\text{C/W}$ |
| Reflow soldering temperature, MSL3 | T_{sold} | 260 | $^{\circ}\text{C}$ |

Note:

a. $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board

**Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)****Static Characteristics**

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|----------------------------------|--------------|--|------|-----|------|---------------|
| Drain-Source Breakdown Voltage | BV_{DSS} | | 650 | -- | -- | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$ | -- | 2 | 20 | μA |
| Gate-body Leakage Current | I_{GSS} | $V_{GS}=6\text{V}, V_{DS}=0\text{V}$ | -- | -- | 200 | μA |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=5\text{mA}$ | 0.95 | -- | 1.50 | V |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS}=6\text{V}, I_D=5\text{A}, T_J=25^\circ\text{C}$ | -- | 170 | 190 | m Ω |
| | | $V_{GS}=6\text{V}, I_D=5\text{A}, T_J=150^\circ\text{C}$ | -- | 390 | -- | |

Dynamic Characteristics

| Parameter | Symbol | Condition | Min | Typ | Max | Unit | |
|---|--------------|---|-----|------|-----|------|----------|
| Input Capacitance | C_{iss} | $V_{DS}=400\text{V}, V_{GS}=0\text{V},$ $f=1.0\text{MHz}$ | | 74 | | pF | |
| Output Capacitance | C_{oss} | | | 24 | | pF | |
| Reverse Transfer Capacitance | C_{rss} | | | 0.36 | | pF | |
| Output Capacitance, energy related ¹ | $C_{o(er)}$ | $V_{GS}=0, V_{DS}=0-400\text{V}$ | | 28 | | pF | |
| Output Capacitance, time related ² | $C_{o(tr)}$ | | | 37 | | pF | |
| Output Charge | Q_{oss} | | | | 15 | | nC |
| Gate Resistance | R_g | | | | 1.0 | | Ω |
| Turn-on Delay Time | $t_{d(on)}$ | $V_{DD}=400\text{V}, I_D=5\text{A}$ $V_{GS}=0-6\text{V}, R_{on}=10\Omega,$ $R_{off}=3\Omega, \text{ See Fig 17.}$ | | 12 | | nS | |
| Turn-on Rise Time | t_r | | | | 7 | | nS |
| Turn-Off Delay Time | $t_{d(off)}$ | | | | 11 | | nS |
| Turn-Off Fall Time | t_f | | | | 9 | | nS |

Gate Charge Characteristics

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|--------------------|----------|--|-----|------|------|------|
| Total Gate Charge | Q_g | $V_{DS}=400\text{V}, I_D=5\text{A},$ $V_{GS}=6\text{V}$ | | 2.0 | | nC |
| Gate-Source Charge | Q_{gs} | | | 0.39 | | nC |
| Gate-Drain Charge | Q_{gd} | | | | 0.67 | |

Reverse Diode Characteristics

| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|-------------------------|----------|-----------------------------------|-----|-----|-----|------|
| Diode Forward Voltage | V_{SD} | $V_{GS}=0\text{V}, I_D=3\text{A}$ | --- | 2.5 | --- | V |
| Reverse Recovery Charge | Q_{rr} | | | 0 | | nC |

Note: 1. $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V

2. $C_{o(tr)}$ is a fixed capacitance that gives the same charge time as C_{oss} while V_{DS} is rising from 0 to 400V



Typical Electrical and Thermal Characteristics

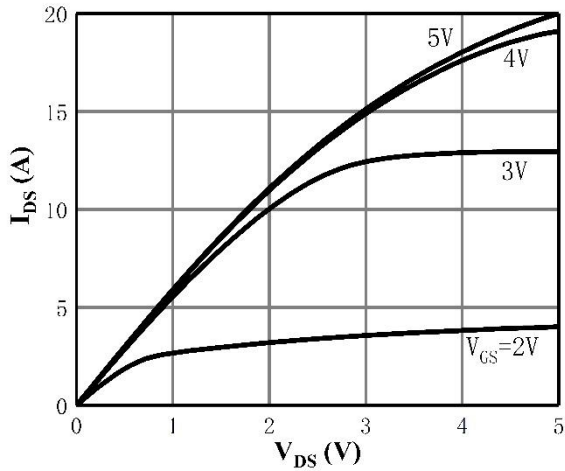


Figure 1. Output Characteristics at 25 °C

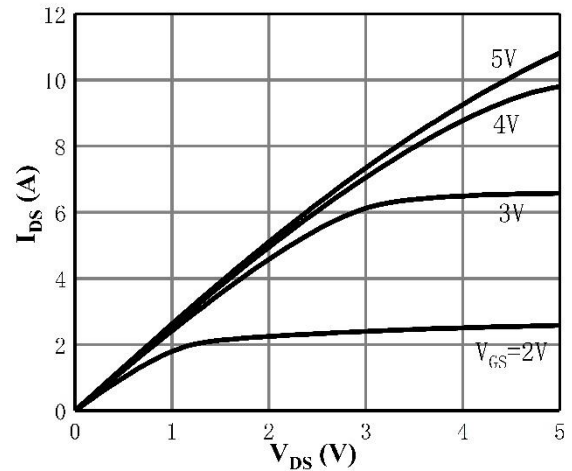


Figure 2. Output Characteristics at 150 °C

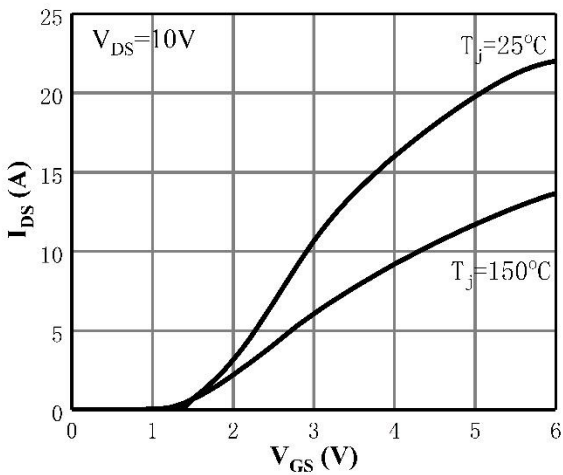


Figure 3. Transfer Characteristics

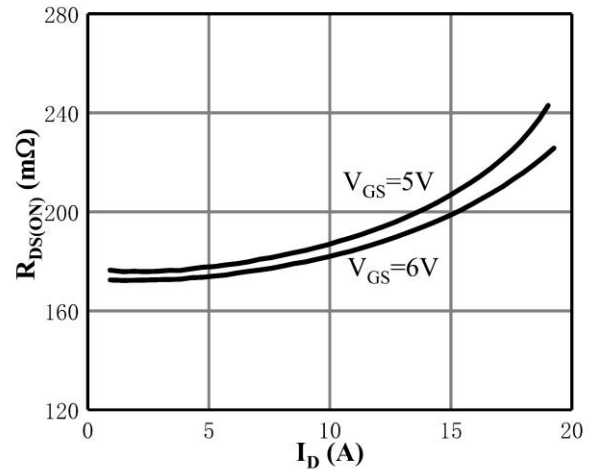


Figure 4. R_DS(on)-Drain Current

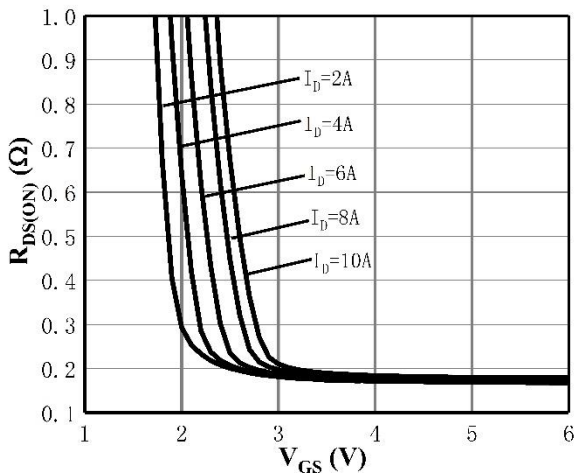


Figure 5. R_DS(on)-Gate Voltage at 25 °C

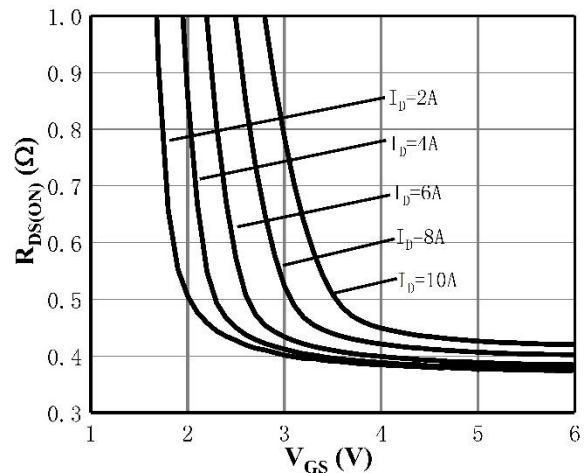


Figure 6. R_DS(on)-Gate Voltage at 150 °C

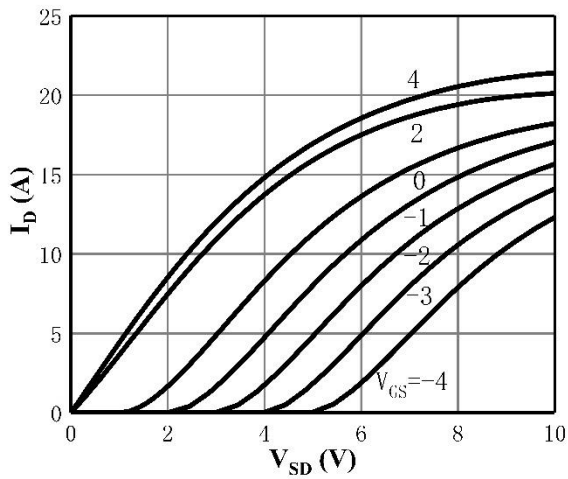


Figure 7. Reverse Characteristics at 25 °C

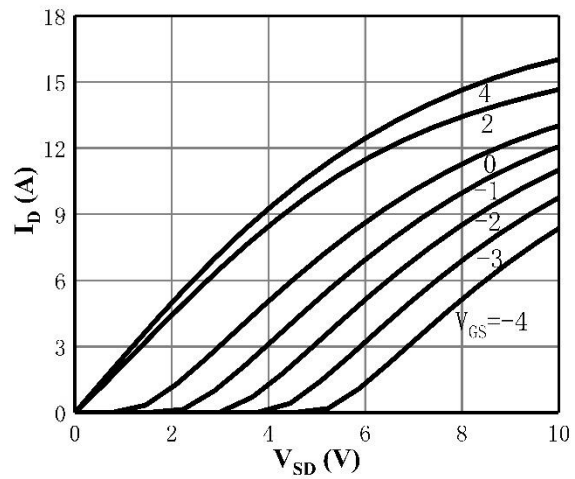


Figure 8. Reverse Characteristics at 150 °C

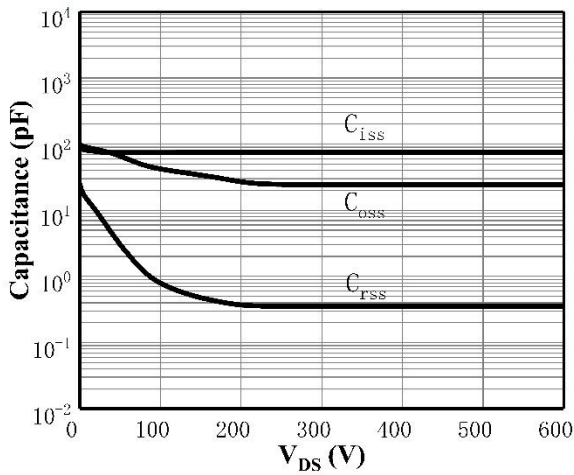


Figure 9. Capacitance vs V_DS

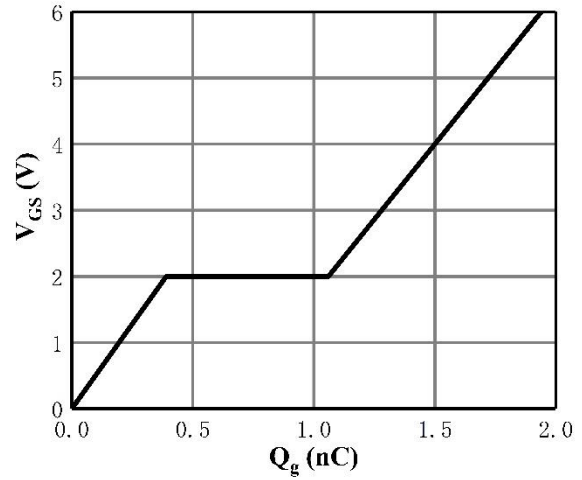


Figure 10. Gate Charge

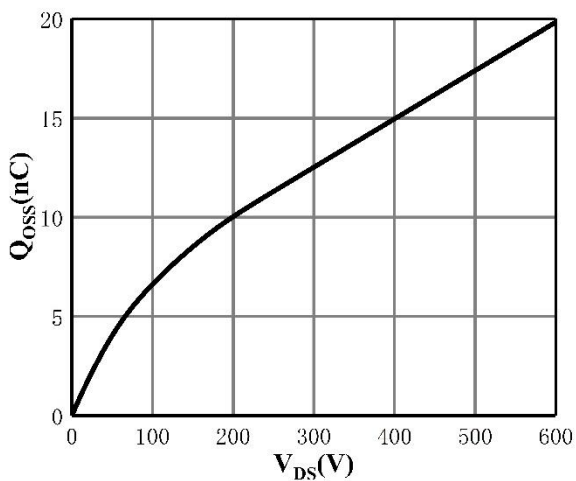


Figure 11. Output Charge

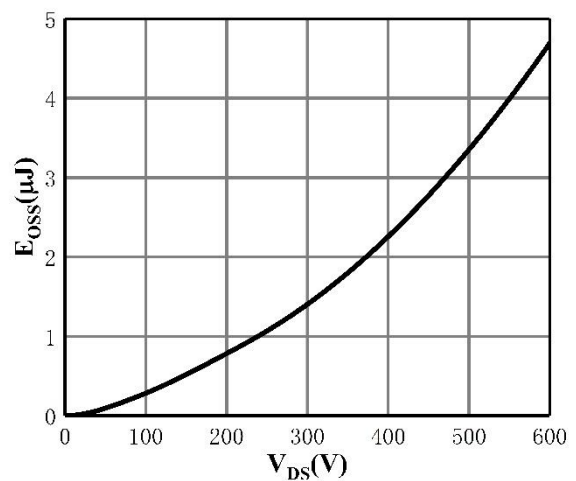


Figure 12. Coss Store Energy

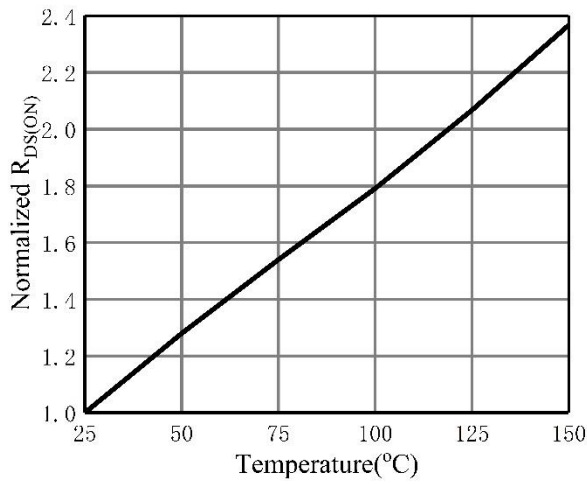


Figure 13. Normalized $R_{DS(ON)}$ vs T_J

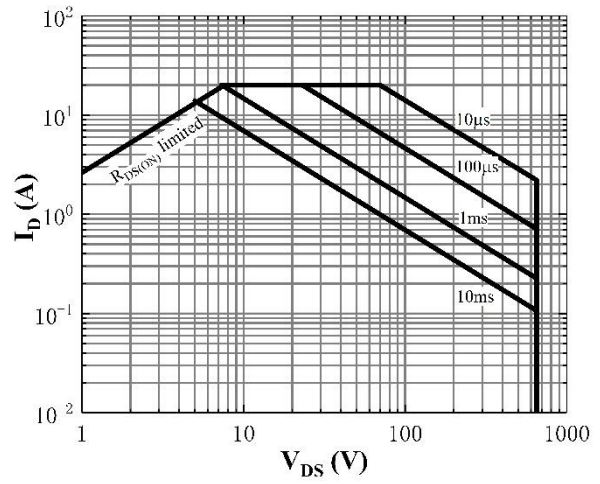


Figure 14. Safe Operating Area

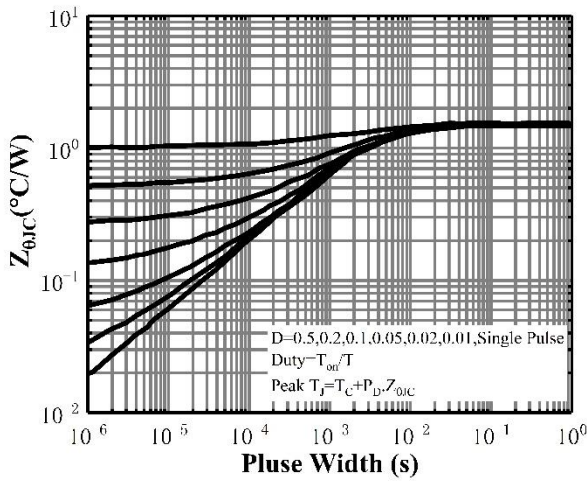


Figure 15. Transient Thermal Resistance

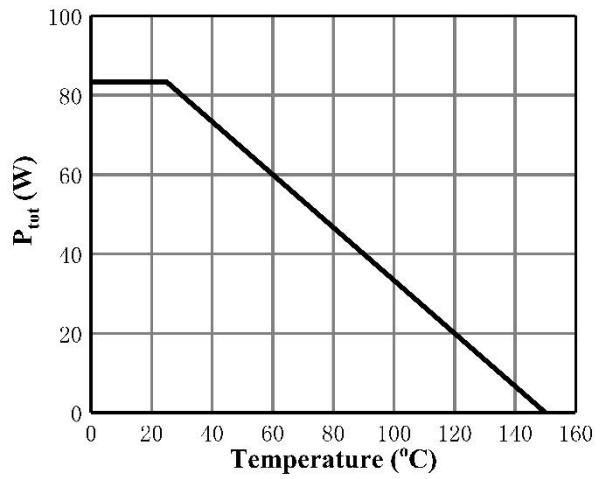


Figure 16. Power Dissipation

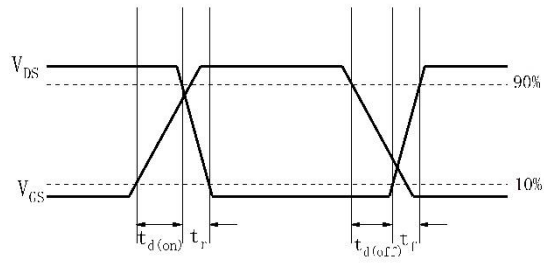
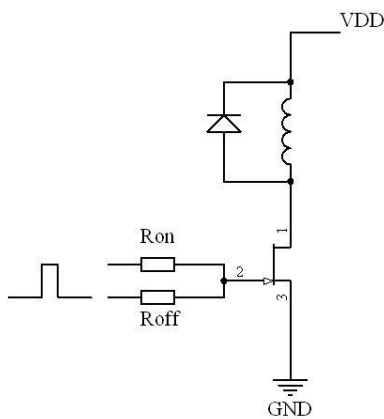
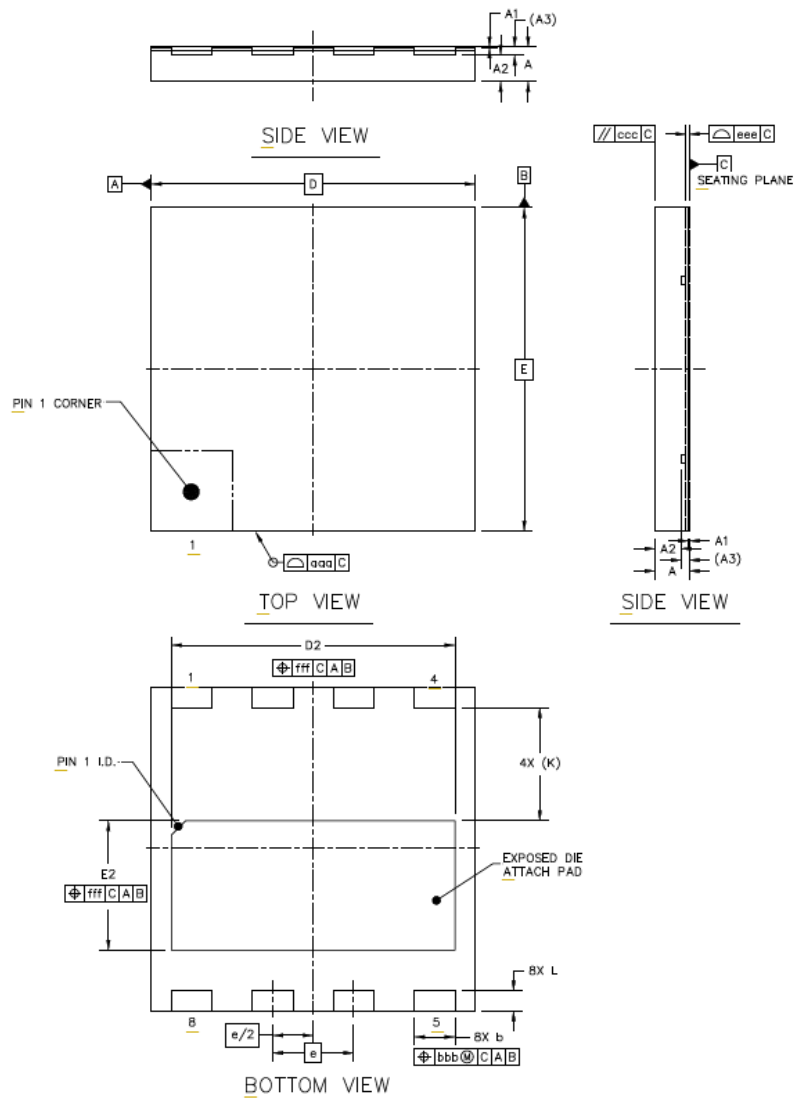


Figure 17. Switching Time Measurement



PQFN8×8 Package Information



| | SYMBOL | MIN | NOM | MAX |
|------------------------------|--------|-----------|------|------|
| TOTAL THICKNESS | A | 0.8 | 0.85 | 0.9 |
| STAND OFF | A1 | 0 | 0.02 | 0.05 |
| MOLD THICKNESS | A2 | --- | 0.65 | --- |
| L/F THICKNESS | A3 | 0.203 REF | | |
| LEAD WIDTH | b | 0.95 | 1 | 1.05 |
| BODY SIZE | X | D | | |
| | Y | E | | |
| LEAD PITCH | e | 2 BSC | | |
| EP SIZE | X | D2 | 6.9 | 7 |
| | Y | E2 | 3.1 | 3.2 |
| LEAD LENGTH | L | 0.4 | 0.5 | 0.6 |
| LEAD TIP TO EXPOSED PAD EDGE | K | 2.8 REF | | |
| PACKAGE EDGE TOLERANCE | aaa | 0.1 | | |
| MOLD FLATNESS | ccc | 0.1 | | |
| COPLANARITY | eee | 0.08 | | |
| LEAD OFFSET | bbb | 0.1 | | |
| EXPOSED PAD OFFSET | fff | 0.1 | | |



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